



PTO/SB/08A (08-03)

<b>Substitute for form 1449A/PTO</b>  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (use as many sheets as necessary)		<b>Complete if Known</b>	
		Application Number	10/081,167
		Filing Date	February 22, 2002
		First Named Inventor	Tonack, Mark
		Art Unit	2113
		Examiner Name	Michael C. Maskulinski
Sheet 1	of 1	Attorney Docket Number	020375-006600US

U.S. PATENT DOCUMENTS+					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number Number Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
MM	A1	US-5,355,083	10-1994	George et al.	
	A2	US-5,541,510	07-1996	Danielson	
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	A32				

Examiner Signature	<i>Michael Maskulinski</i>	Date Considered	11/20/05
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. <sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> Kind Codes of U.S. Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 801.04. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.  
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PTO/SB/08B (08-03)

Substitute for form 1449B/PTO				<b>Complete if Known</b>	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (use as many sheets as necessary)				Application Number	10/081,167
				Filing Date	February 22, 2002
				First Named Inventor	Tonack, Mark
				Art Unit	2113
				Examiner Name	Michael C. Maskulinski
Sheet	1	of	1	Attorney Docket Number	020375-006600US

U.S. PATENT DOCUMENTS+					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number Number Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
MM	A1	US-5,983,911	10-05-1999	Walker et al.	
	A2	US-6,032,184	02-29-2000	Cogger et al.	
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Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document			Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
		Country Code <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup> (if known)				
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	B							<input type="checkbox"/>
	C							<input type="checkbox"/>
	D							<input type="checkbox"/>
	E							<input type="checkbox"/>
	F							<input type="checkbox"/>
	AA							<input type="checkbox"/>
	AB							<input type="checkbox"/>

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
	AC		
	AD		
	AE		
	AF		

Examiner Signature	<i>Michael Maskulinski</i>	Date Considered	11/20/05
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